TOSHIBA MG400Q1US51

TOSHIBA GTR MODULE SILICON N CHANNEL IGBT

MG400Q1US51

HIGH POWER SWITCHING APPLICATIONS

MOTOR CONTROL APPLICATIONS

• High Input Impedance

• High Speed : $t_f = 0.3 \mu s$ (Max.)

@Inductive Load

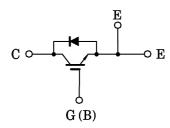
• Low Saturation Voltage

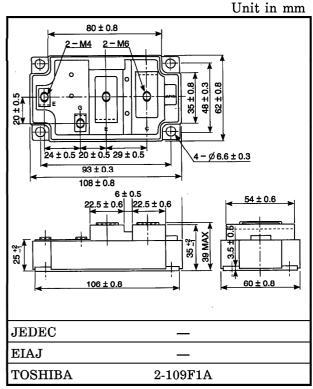
: $V_{CE (sat)} = 3.6V (Max.)$

• Enhancement-Mode

• The Electrodes are Isolated from Case.

EQUIVALENT CIRCUIT





Weight: 465g

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT	
Collector-Emitter Voltage	v_{CES}	1200	V		
Gate-Emitter Voltage	$v_{ m GES}$	±20	V		
Collector Current	DC	I _C (25°C/80°C)	520 / 400	A	
	1ms	I _{CP} (25°C/80°C)	1040 / 800		
E	DC	$I_{\mathbf{F}}$	400	۸	
Forward Current	1ms	I_{FM}	800	Α	
Collector Power Dissipation (Tc=25°C	PC	3000	W		
Junction Temperature	T_{j}	150	°C		
Storage Temperature Range	$ m T_{stg}$	-40~125	°C		
Isolation Voltage	$ m v_{Isol}$	2500			
Screw Torque (Terminal: M4/M6/Mounting)		_	2/3/3	N∙m	

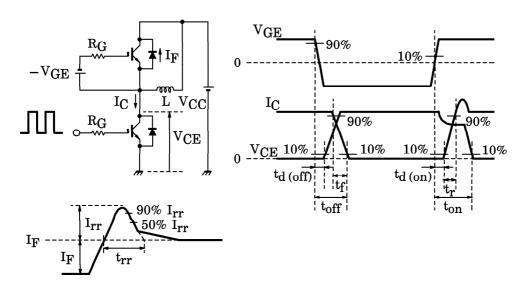
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ELECTRICAL	CHARACTERISTICS	$(Ta = 25^{\circ}C)$
	CHANACIENISTICS	114 - 23 C/

СНА	RACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		$I_{ ext{GES}}$	$V_{GE} = \pm 20V, V_{CE} = 0$		_	±500	nA
Collector Cut-off Current		ICES	$V_{CE} = 1200V, V_{GE} = 0$	_	_	4.0	mA
Gate-Emitter Cut-off Voltage VGE (c		V _{GE (off)}	$I_{C}=400 \text{mA}, V_{CE}=5 \text{V}$	3.0	_	6.0	V
Collector-E	Collector-Emitter		$I_{\rm C} = 400 {\rm A}, \qquad T_{\rm j} = 25 {\rm °C}$	_	2.8	3.6	v
Saturation	Voltage	V _{CE} (sat)	$V_{ m GE} = 15 m V$ $T_{ m j} = 125^{\circ}$	c —	3.1	4.0	1 ' I
Input Cap	acitance	$\mathrm{c}_{\mathrm{ies}}$	$V_{CE} = 10V, V_{GE} = 0, f = 1MH$	z	44.0	-	nF
Switching Time	Turn-on Delay Time	^t d (on)	Inductive Load	I —	0.05	-	
	Rise Time	$t_{\mathbf{r}}$	$V_{CC} = 600V$	_	0.05	_	
	Turn-on Time	t_{on}	$I_{\rm C}=400{\rm A}$		0.2	_]
	Turn-off Delay Time	td (off)	$V_{GE} = \pm 15V$	_	0.5	_	μs
	Fall Time	t_f	$R_G = 2.4\Omega$	_	0.1	0.3	
	Turn-off Time	$t_{ m off}$	(Note 1)	0.6	_	
Forward V	oltage	$V_{\mathbf{F}}$	$I_{F} = 400A, V_{GE} = 0$		2.4	3.5	V
Reverse Recovery Time		t _{rr}	$I_{F} = 400A, V_{GE} = -10V$		_ 0.25	0.45	1
			$di/dt = 1000A/\mu s$ (Note 1) -	0.20	0.45	μ s
Thermal Resistance		R _{th (j-c)}	Transistor Stage		_	0.042	°C/W
			Diode Stage		_	0.12	

(Note 1) Switching Time and Reverse Recovery Time Test Circuit & Timing Chart



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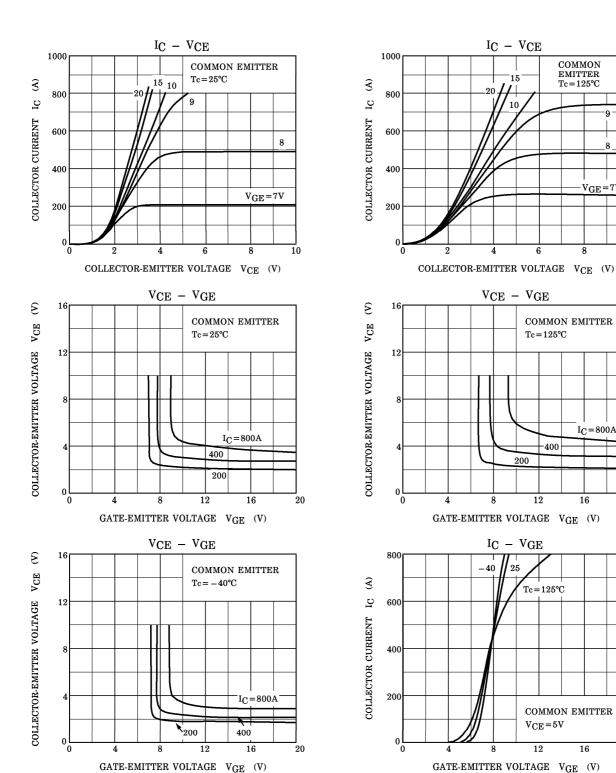
COMMON EMITTER Tc=125°C

 $V_{GE} = 7V$

 $I_C = 800A$

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